

-40V P-Channel Enhancement Mode MOSFET

Description

The AP5P04MI uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

$V_{DS} = -40V$ $I_D = -5.0A$

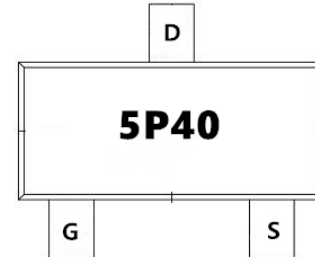
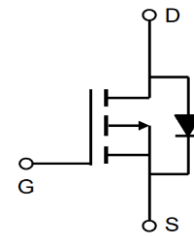
$R_{DS(ON)} < 72m\Omega$ @ $V_{GS} = -10V$ (Type: 65m Ω)

Application

Battery protection

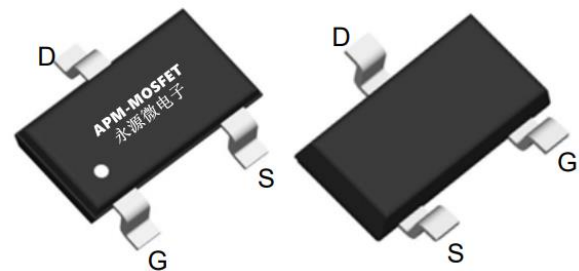
Load switch

Uninterruptible power supply



Top View

Bottom View



Package Marking and Ordering Information

| Product ID | Pack | Marking | Qty(PCS) |
|------------|----------|---------|----------|
| AP5P04MI | SOT23-3L | 5P40 | 3000 |

Absolute Maximum Ratings ($T_C = 25^\circ C$ unless otherwise noted)

| Symbol | Parameter | Steady State | Units |
|--------------------------|--|--------------|--------------|
| V_{DS} | Drain-Source Voltage | -40 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D @ T_A = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ -4.5V^1$ | -5.0 | A |
| $I_D @ T_A = 70^\circ C$ | Continuous Drain Current, $V_{GS} @ -4.5V^1$ | -3.0 | A |
| I_{DM} | Pulsed Drain Current ² | -16.1 | A |
| $P_D @ T_A = 25^\circ C$ | Total Power Dissipation ³ | 1.32 | W |
| $P_D @ T_A = 70^\circ C$ | Total Power Dissipation ³ | 0.84 | W |
| TSTG | Storage Temperature Range | -55 to 150 | $^\circ C$ |
| T_J | Operating Junction Temperature Range | -55 to 150 | $^\circ C$ |
| $R_{\theta JA}$ | Thermal Resistance Junction-Ambient ¹ | 125 | $^\circ C/W$ |
| $R_{\theta JC}$ | Thermal Resistance Junction-Case ¹ | 80 | $^\circ C/W$ |

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Electrical Characteristics (T_J=25°C, unless otherwise noted)

| Symbol | Parameter | Conditions | Min. | Typ | Max. | Unit |
|------------------------|--|--|------|--------|-------|-------|
| BVDSS | Drain-Source Breakdown Voltage | V _{GS} =0V, I _D =-250uA | -40 | -46 | --- | V |
| ΔBVDSS/ΔT _J | BV _{DSS} Temperature Coefficient | Reference to 25°C, I _D =-1mA | --- | -0.018 | --- | V/°C |
| RDS(ON) | Static Drain-Source On-Resistance ² | V _{GS} =-4.5V, I _D =-3A | --- | 65 | 72 | mΩ |
| | | V _{GS} =-2.5V, I _D =-2A | --- | 89 | 100 | |
| VGS(th) | Gate Threshold Voltage | V _{GS} =V _{DS} , I _D =-250uA | -1.0 | -1.5 | -2.5 | V |
| ΔVGS(th) | VGS(th) Temperature Coefficient | | --- | 2.5 | --- | mV/°C |
| IDSS | Drain-Source Leakage Current | V _{DS} =-24V, V _{GS} =0V, T _J =25°C | --- | --- | -1 | uA |
| | | V _{DS} =-24V, V _{GS} =0V, T _J =55°C | --- | --- | -5 | |
| IGSS | Gate-Source Leakage Current | V _{GS} =±20V, V _{DS} =0V | --- | --- | ±100 | nA |
| gfs | Forward Transconductance | V _{DS} =-5V, I _D =-3A | --- | 5.8 | --- | S |
| Q _g | Total Gate Charge (-4.5V) | V _{DS} =-32V, V _{GS} =-4.5V, I _D =-3A | --- | 6.4 | --- | nC |
| Qgs | Gate-Source Charge | | --- | 2.1 | --- | |
| Qgd | Gate-Drain Charge | | --- | 2.5 | --- | |
| Td(on) | Turn-On Delay Time | V _{DD} =-20V, V _{GS} =-4.5V, R _G =3.3Ω, I _D =-3A | --- | 4.2 | --- | ns |
| T _r | Rise Time | | --- | 23 | --- | |
| Td(off) | Turn-Off Delay Time | | --- | 26.8 | --- | |
| T _f | Fall Time | | --- | 20.6 | --- | |
| Ciss | Input Capacitance | V _{DS} =-15V, V _{GS} =0V, f=1MHz | --- | 620 | --- | pF |
| Coss | Output Capacitance | | --- | 65 | --- | |
| Crss | Reverse Transfer Capacitance | | --- | 53 | --- | |
| IS | Continuous Source Current ^{1,4} | V _G =V _D =0V, Force Current | --- | --- | -5.2 | A |
| ISM | Pulsed Source Current ^{2,4} | | --- | --- | -16.1 | A |
| VSD | Diode Forward Voltage ² | V _{GS} =0V, I _S =-1A, T _J =25°C | --- | --- | -1 | V |

Note :

- 1、The data tested by surface mounted on a 1 inch FR-4 board with 2OZ copper.
- 2、The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3、The power dissipation is limited by 150°C junction temperature
- 4、The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

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Typical Characteristics

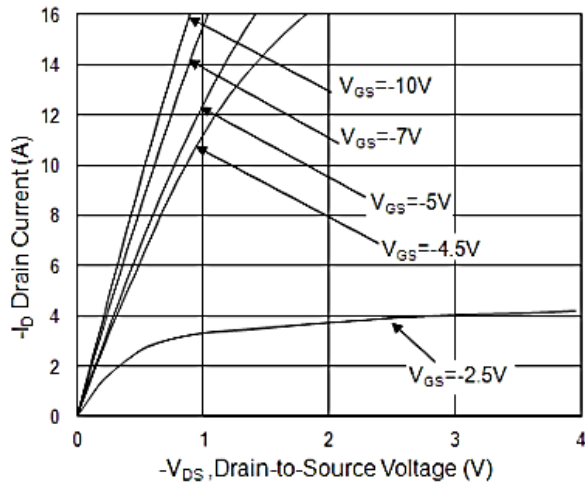


Fig.1 Typical Output Characteristics

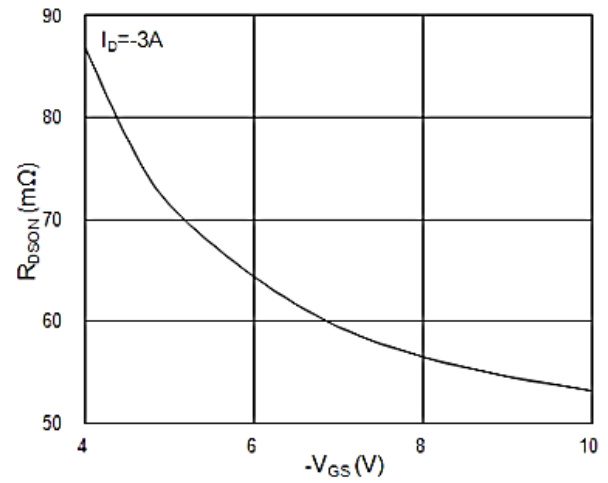


Fig.2 On-Resistance vs. G-S Voltage

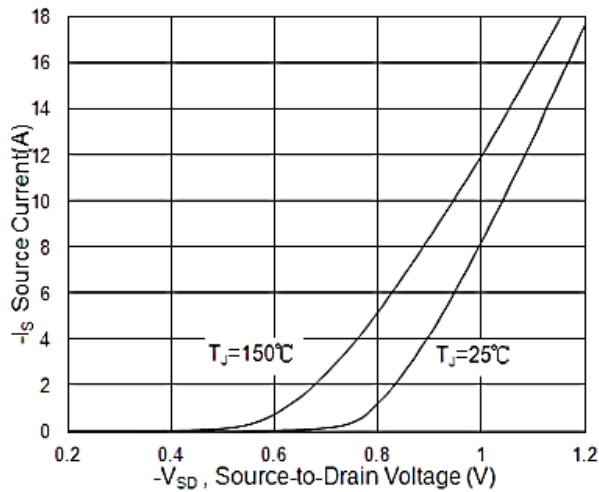


Fig.3 Forward Characteristics Of Reverse

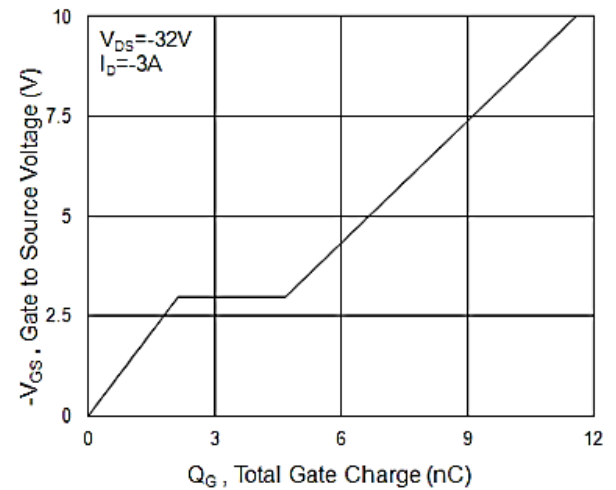


Fig.4 Gate-Charge Characteristics

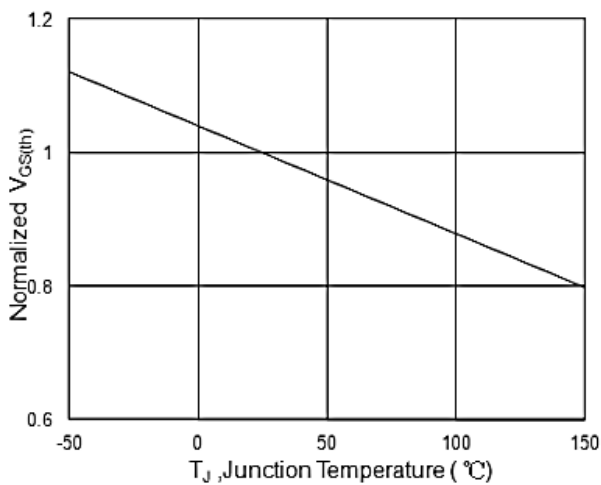


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

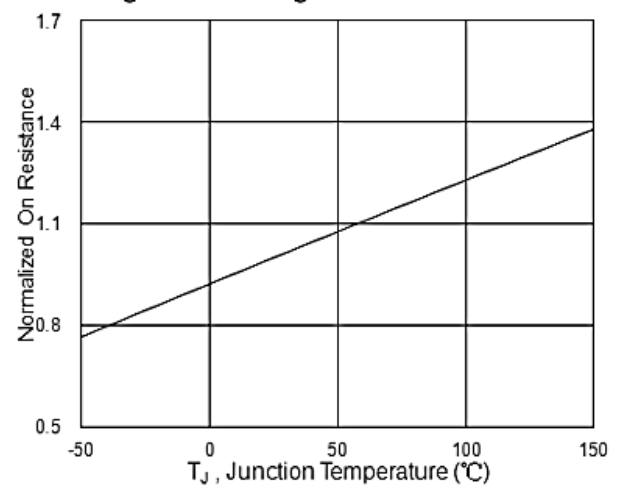


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

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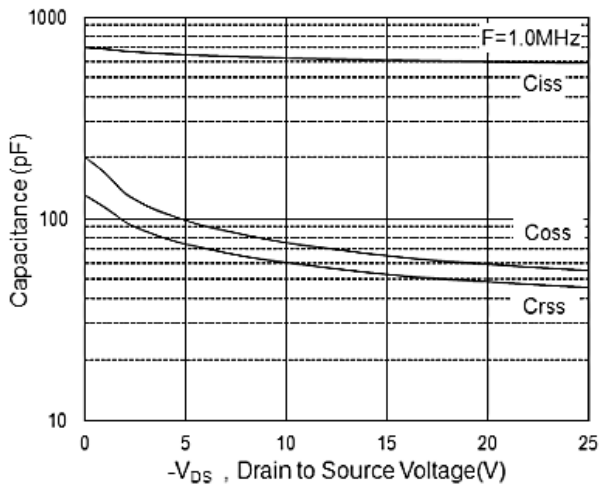


Fig.7 Capacitance

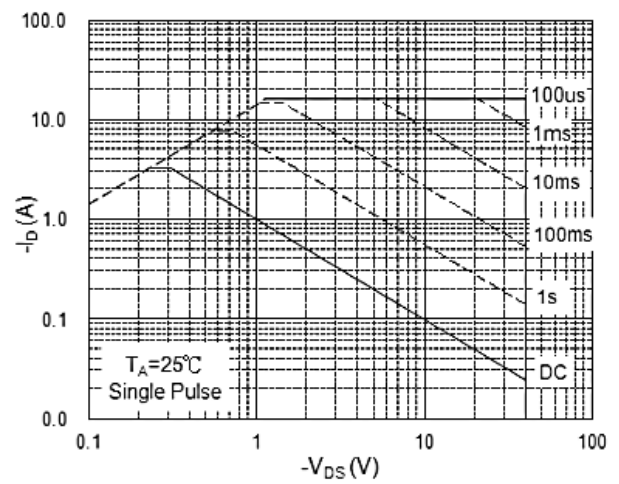


Fig.8 Safe Operating Area

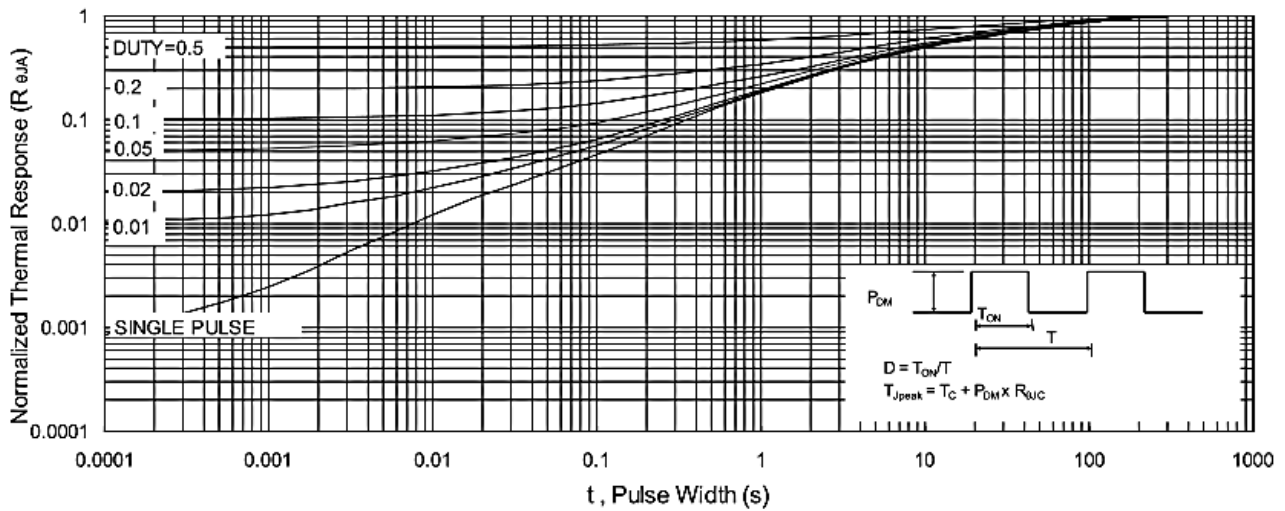


Fig.9 Normalized Maximum Transient Thermal Impedance

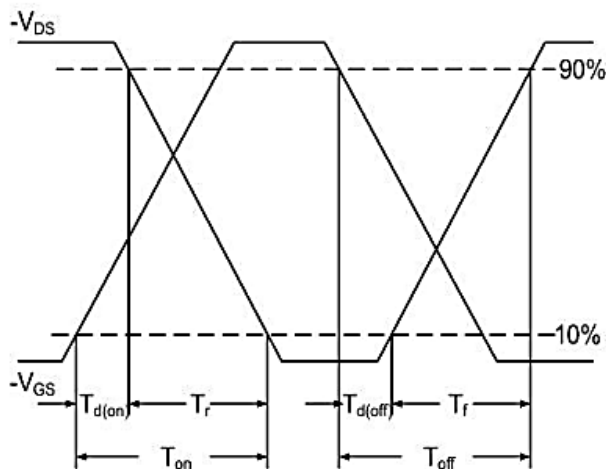


Fig.10 Switching Time Waveform

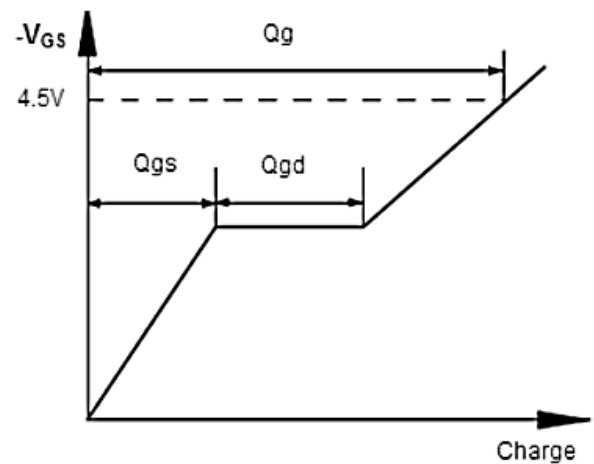
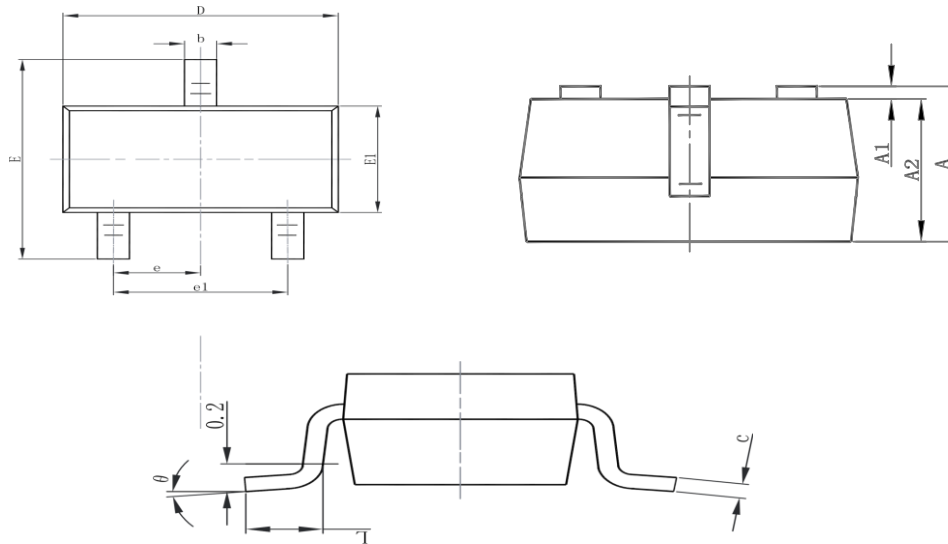


Fig.11 Gate Charge Waveform

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Package Mechanical Data:SOT23-3L



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|-------|----------------------|-------|
| | Min. | Max. | Min. | Max. |
| A | 1.050 | 1.250 | 0.041 | 0.049 |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 |
| A2 | 1.050 | 1.150 | 0.041 | 0.045 |
| b | 0.300 | 0.500 | 0.012 | 0.020 |
| c | 0.100 | 0.200 | 0.004 | 0.008 |
| D | 2.820 | 3.020 | 0.111 | 0.119 |
| E1 | 1.500 | 1.700 | 0.059 | 0.067 |
| E | 2.650 | 2.950 | 0.104 | 0.116 |
| e | 0.950(BSC) | | 0.037(BSC) | |
| e1 | 1.800 | 2.000 | 0.071 | 0.079 |
| L | 0.300 | 0.600 | 0.012 | 0.024 |
| θ | 0° | 8° | 0° | 8° |

-40V P-Channel Enhancement Mode MOSFET Attention

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